

Towards hadronic shower timing with CALICE Analog Hadron Calorimeter

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- 2006 2011: first generation of AHCAL prototype
- 2011 ongoing: second generation of AHCAL prototype
- Physics motivation
- Commissioning of the first layer
- Summary and Outlook







Highly granular calorimeters





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A second generation AHCAL prototype



<u>Second generation prototype</u>:
Scalable technology
Integrated readout electronics



Plastic scintillatorWLS fiberGreen sensitive SiPM

3 cm x 3 cm x 0.3 cm

144 tiles mounted on each HCAL Base Unit (HBU)

Read out chips (SPIROC2b)

- 36 channels/chip
- One threshold discriminator per channel
- one ADC per channel
- one TDC per channel
- Low power consumption (25 μW/channel)

4 HBUs assembled together to form a layer

Technological motivation: test integrated readout electronics





More details in talk from K. Krueger

Hadronic shower timing



180 GeV π- QGSP_BERT_HP



First timing experiment in CALICE (T3B)One dimensional: row of 15 detectorsPicosecond resolution (not scalable)

see talk from F. Simon

provided first check of Physics Lists timing

Late neutron component in hadronic showers: Impact on Particle Flow Algorithm •Estimate effect of pile-up (CLIC)

•Improve shower reconstruction with time cuts



•Nanosecond resolution scalable technology

- •One layer (soon: multi-layer prototype)
- Test of the time-stamping capabilities
 Apply shower reconstruction algorithm
 Estimate impact of late component





-multi-layer

The readout chip



Autotrigger:



The readout chip has been optimized for LC operation

Clock synchronized with beam

Not synchronized in test beam operation

External signal from scintillators to provide:

- 1) absolute time reference
- 2) event validation





Threshold calibration



DESY test beam: 3 GeV e- on individual tiles



- Individual threshold adjustment
- Test for the event validation

- Spread of the MIP most probable value ~ 10% This value includes:
- Individual SiPM bias adjustment
- •SiPM gain equalization via pre-amplifiers HBU mounted





Time stamping:

- a) 2 multiplexed voltage ramps per chip (adj. length)
 - 5 µs long
- b) voltage value at hit is stored in memory cell
 - 5 µs/4096 bins ~ **1.2 ns/bin**
- Ramp calibration (charge injection with a pulser):



To be done for $16 \times 36 \times 16 = 9216$ memory cells: calibration still ongoing!





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DER FORSCHUNG | DER LEHRE | DER BILDUNG

time [ns] = f(TDC) + offset



CERN test beam







Test beam at CERN SPS:

- Experiments set in conditioned tent: stable temperature conditions
- Muon runs for further MIP calibration
- Pion runs
 - → at 50 GeV and 180 GeV
- Trigger scintillators in coincidence
 - → into two AHCAL channels for absolute time reference



CERN data

Universität Hamburg Der Forschung | Der Lehre | Der Bildung

#Hits 180 GeV muons 180 GeV pions Number of hits Number of hits numberofhits numberofhite Entries 859228 Tile position (Y) Amplitude [MIP 19.95 Entries 1259779 7.588 Mean x 15.44 5.561 Mean y 9.944 RMS x RMS y 6.16 RMS x 6.194 RMS V 5.408 10 12 6 8 10 14 16 18 20 22 10 15 20 Tile position (X) Tile position (X) 12 14 16 18 20 22 2 4 6 10 Tile position (X

- More than 400k muons
- Pion event reconstruction finalized:
 - → 420k pion events reconstructed at 180 GeV
 - → 86k pion events reconstructed at 50 GeV
- MIP calibration ongoing
- TDC calibration still ongoing





CERN data quality

Muon data

cross-check of threshold calibration:

- Homogeneity of MIP positions
- Successful test for external validation:
 - → Threshold < 0.5 MIP</p>
 - Noise < 50 Hz/HBU (up to 700 Hz/HBU w/out validation)
 - → Beam rate 1 50 Hz
- Noise peak due to inefficiency of external validation
 - → Known feature of the readout chip
 - Fixed in following versions





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Upcoming test beam



Next test beam:

- Two weeks in June 2013
- DESY electron beam line 22
- 2-6 GeV electrons

Multi-layer setup:

- Commissioning and test:
 - → New Front End electronics
 - → New DAQ
- New tile prototypes
 - → New solutions for simplification
 - → Mass production









UniHH fully wrapped



NIU "megatile"



Conclusions

- One layer of new AHCAL prototype successfully commissioned:
 - Integrated readout electronics →
 - Time stamping capabilities (main physics goal) →
- Extensive calibration procedure
 - Full understanding of the electronics
- Hadronic test beam campaign at CERN SPS
 - Data analysis just starting →

Outlook:

- Commissioning of a multi-layer prototype
 - Focus on DAQ development
- •First test at DESY test beam in June 2013
- •Total of 20 HBUs envisaged for 2014
 - Bring multi-layer prototype in hadronic test beam











TDC calibration at DESY test beam





- HBU in DESY electron test beam:
- Aluminum absorber ($R_{M} \sim 4.4 \text{ cm}$)
- Wide, "instantaneous" EM showers
- Each shower hits several cells simultaneously
- Two channels replaced with external trigger from scintillator for absolute time reference
- chip clock not synchronous with the beam
- We cover the whole TDC ramp range





TDC ramp accuracy





The two multiplexed ramps are not equal to a level of $\sim 1\%$ Still not enough: deviation corresponds to a difference of tens of ns



TDC ramp linearity



Linear ramp approximation:

time [ns] = slope x TDC + offset



Linear approximation still not good enough: Residuals up to 10 ns between real data and fit Instead of fit function: Look up table of data points for interpolation

New tile prototypes



Reduce the spread in tile performances:

•Remove wavelength-shifting fiber

- → Use blue sensitive SiPM
- •Enhance tile uniformity (Light Yield uniformity)
- •Enhance SiPM performances uniformity
 - → SiPM mass production
 - → Ensure calibration portability

	СРТА	Ketek	
Gain [e-]	0.7 x 10 ⁶ to 2 x10 ⁶	0.8 x10 ⁶	
PDE [%]	n.a.	30 (at λ= 420 nm)	
DCR (at 0.5 p.e.)	1 Mcps	1 Mcps	
Cross-talk [%]	~ 1%	10 %	
Recovery [ns]	80	50	
Breakdown [V]	28	26	
dV _{BD} /dT [mV/K]	20	23	
Area	1 mm x 1 mm	1.2 mm x 1.2 mm	
N of pixels	798	2300	



UniHH tile



[p.e.] Light Yield scan (same SiPM as reference)

	ITEP	UniHH
Mean LY [p.e.]	14	23
10% deviation area	76 %	91 %